

<b>Notice of References Cited</b>	Application/Control No. 10/590,112	Applicant(s)/Patent Under Reexamination HORIUCHI ET AL.	
	Examiner MARK TSIDULKO	Art Unit 2875	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0174803	08-2005	Hayashi et al.	362/608
*	B	US-6,164,790	12-2000	Lee, Jong Hoon	362/618
	C	US-			
	D	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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